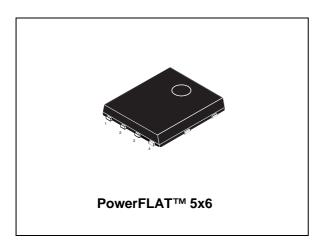


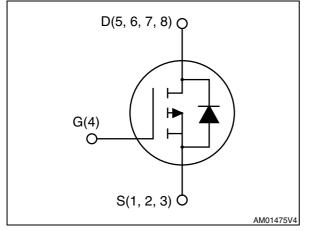
# STL12P6F6

Datasheet - production data

### P-channel 60 V, 0.13 Ω typ., 3 A STripFET<sup>™</sup> VI DeepGATE<sup>™</sup> Power MOSFET in a PowerFLAT<sup>™</sup> 5x6 package



#### Figure 1. Internal schematic diagram



#### Features

Order code	$v_{\text{DSS}}$	R <sub>DS(on)max</sub>	I <sub>D</sub>
STL12P6F6	60 V	0.16 Ω @ 10 V	3 A

- R<sub>DS(on)</sub> \* Qg industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate drive power losses

### **Applications**

• Switching applications

#### Description

This device is a P-channel Power MOSFET developed using the 6<sup>th</sup> generation of STripFET<sup>™</sup> DeepGATE<sup>™</sup> technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R<sub>DS(on)</sub> in all packages.

#### Table 1. Device summary

Order code	Order code Marking		Packaging	
STL12P6F6	12P6F6	PowerFLAT 5x6	Tape and reel	

Note: For the P-channel Power MOSFET the actual polarity of the voltages and the current must be reversed.

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This is information on a product in full production.

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### 1 Electrical ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	60	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
Ι <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	4	A
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100 °C	7	A
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>pcb</sub> = 25 °C	12	A
I <sub>D</sub> <sup>(2)</sup>	Drain current (continuous) at T <sub>pcb</sub> = 100 °C	7	A
I <sub>DM</sub> <sup>(2)(3)</sup>	Drain current (pulsed)	48	A
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \ ^{\circ}C$	75	W
P <sub>TOT</sub>	Total dissipation at $T_{pcb}$ = 25 °C	4.8	W
T <sub>j</sub> P <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 175	°C

1. The value is according to  $R_{thj\text{-}case}$ 

2. The value is according to  $R_{thj-pcb}$ 

3. Pulse width is limited by safe operating area.

#### Table 3. Thermal data

Symbol Parameter		Value	Unit
R <sub>thj-case</sub> Thermal resistance junction-case max		2	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup> Thermal resistance junction-pcb max		31.3	°C/W

1. When mounted on FR-4 board of 15  $\text{mm}^2$ , 2 Oz Cu, t<10 sec



Note: For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.

### 2 Electrical characteristics

(Tcase = 25 °C unless otherwise specified).

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage (V <sub>GS</sub> = 0)	I <sub>D</sub> = 250 μA	60			V
I <sub>DSS</sub>		V <sub>DS</sub> = 60 V V <sub>DS</sub> = 60 V, T <sub>C</sub> =125 °C			1 10	μΑ μΑ
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2		4	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.5 A		0.13	0.16	Ω

Table 4. On /off states

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	340	-	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> = 48 V, f = 1 MHz, V <sub>GS</sub> = 0	-	40	-	pF
C <sub>rss</sub>	Reverse transfer capacitance		-	20	-	pF
Qg	Total gate charge	V <sub>DD</sub> = 48 V, I <sub>D</sub> = 3 A, V <sub>GS</sub> = 10 V	-	6.4	-	nC
Q <sub>gs</sub>	Gate-source charge		-	1.7	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 3)	-	1.7	-	nC

#### Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	V <sub>DD</sub> = 48 V, I <sub>D</sub> = 1.5 A, R <sub>G</sub> = 4.7 Ω, V <sub>GS</sub> = 10 V (see <i>Figure 2</i> )	-	6.4	-	ns
t <sub>r</sub>	Rise time		-	5.3	-	ns
t <sub>d(off)</sub>	Turn-off delay time		-	14	-	ns
t <sub>f</sub>	Fall time		-	3.7	-	ns

Note: For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)		-		3 12	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 3 A, V <sub>GS</sub> = 0	-		1.1	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 5 A, di/dt = 100 A/µs	-	20		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 16 V, T <sub>j</sub> = 150 °C	-	17.8		nC
I <sub>RRM</sub>	Reverse recovery current	(see <i>Figure 4</i> )	-	1.8		А

Table 7. Source drain diode

1. Pulse width limited by safe operating area.

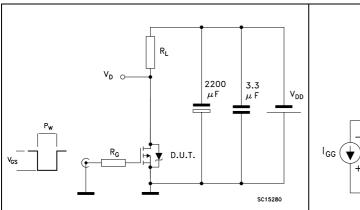
2. Pulse duration = 300  $\mu$ s, duty cycle 1.5%

*Note:* For the P-channel Power MOSFET actual polarity of voltages and current has to be reversed.

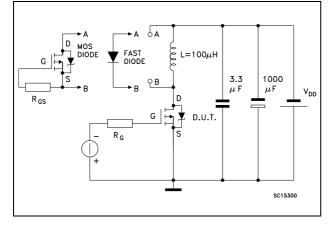


## 3 Test circuits

Figure 2. Switching times test circuit for resistive load



# Figure 4. Test circuit for inductive load switching and diode recovery times



 $G \rightarrow f$ 

Figure 3. Gate charge test circuit



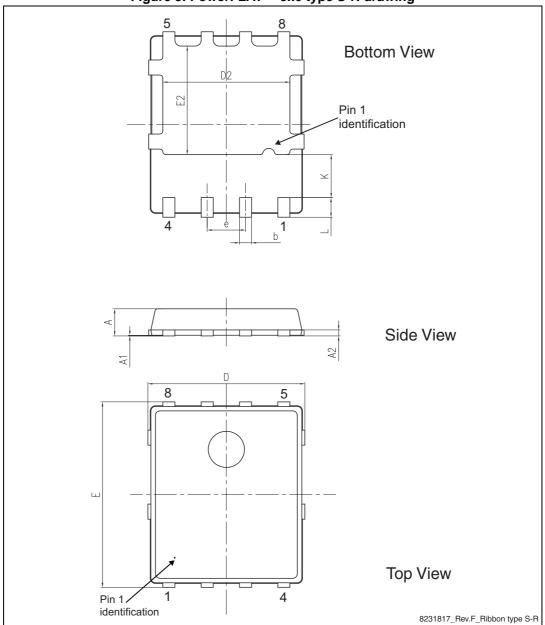
### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

Dim.		mm				
Dim.	Min.	Тур.	Max.			
А	0.80		1.00			
A1	0.02		0.05			
A2		0.25				
b	0.30		0.50			
D	5.00	5.20	5.40			
E	5.95	6.15	6.35			
D2	4.11		4.31			
E2	3.50		3.70			
е		1.27				
L	0.60		0.80			
К	1.275		1.575			

Table 8. PowerFLAT 5x6 type S-R mechanical data









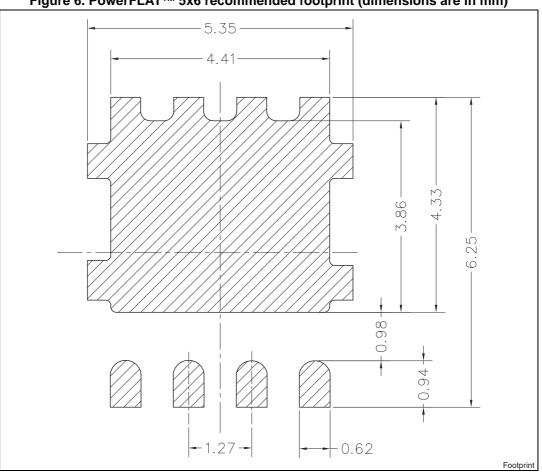


Figure 6. PowerFLAT<sup>™</sup> 5x6 recommended footprint (dimensions are in mm)



### 5 Packaging mechanical data

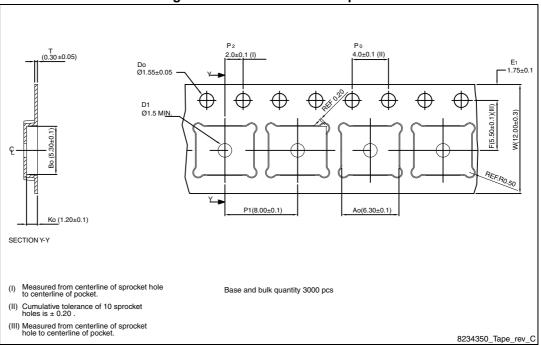
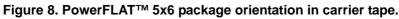
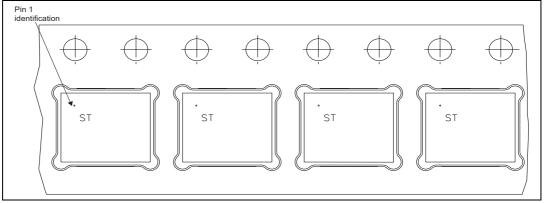


Figure 7. PowerFLAT™ 5x6 tape<sup>(a)</sup>

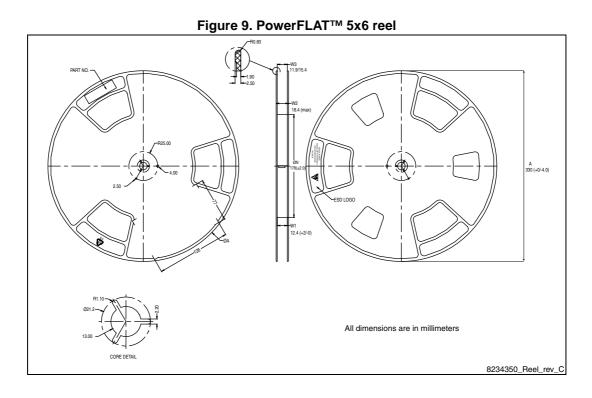




a. All dimensions are in millimeters.

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## 6 Revision history

Date	Revision	Changes
20-Mar-2013	1	First release.



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